

Description

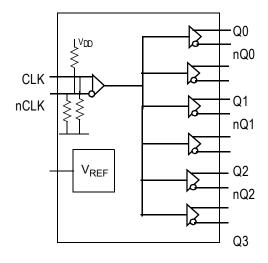
The 8P34S1106I is a high-performance differential LVDS fanout buffer. The device is designed for the fanout of high-frequency, very low additive phase-noise clock and data signals. The 8P34S1106I is characterized to operate from a 1.8V power supply.

Guaranteed output-to-output and part-to-part skew characteristics make the 8P34S1106I ideal for those clock distribution applications demanding well-defined performance and repeatability. One differential input and six low skew outputs are available. The integrated bias voltage reference enables easy interfacing of single-ended signals to the differential device input. The device is optimized for low power consumption and low additive phase jitter.

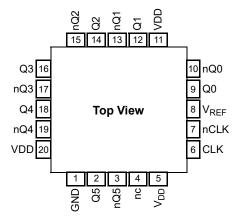
Features

- · Six low skew, low additive jitter LVDS output pairs
- One differential clock input pair
- Differential CLK, nCLK pair can accept the following differential input levels: LVDS, CML
- Maximum input clock frequency: 1.2GHz (maximum)
- Output skew: 20ps (typical)
- Propagation delay: 290ps (typical)
- Low additive phase jitter, RMS; f_{REF} = 156.25MHz, V_{PP} = 1V, 12kHz-20MHz: 39fs (typical)
- Full 1.8V supply voltage
- · Lead-free (RoHS 6), 20-Lead VFQFN packaging
- -40°C to 85°C ambient operating temperature

Block Diagram



Pin Assignment



8P34S1106I 20-VFQFPN 4 x 4 x 0.9 mm package body 2.1 x 2.1 mm ePad Size NLG Package Top View



Pin Description and Pin Characteristic Tables

Table 1. Pin Descriptions $^{[a]}$

Number	Name	Ту	/pe	Description
1	GND	Power		Power supply ground.
2, 3	Q5, nQ5	Output		Differential output pair 5. LVDS interface levels.
4	NC	Unused		Do not connect.
5, 11, 20	V _{DD}	Power		Power supply pins.
6	CLK	Input	Pulldown	Non-inverting differential clock/data input.
7	nCLK	Input	Pulldown/ Pullup	Inverting differential clock/data input.
8	V _{REF}			Bias voltage reference. Provides an input bias voltage for the CLK, nCLK input pair in AC-coupled applications. Refer to <i>Figures 2B and 2C</i> for applicable AC-coupled input interfaces.
9, 10	Q0, nQ0	Output		Differential output pair 0. LVDS interface levels.
12, 13	Q1, nQ1	Output		Differential output pair 1. LVDS interface levels.
14, 15	Q2, nQ2	Output		Differential output pair 2. LVDS interface levels.
16, 17	Q3, nQ3	Output		Differential output pair 3. LVDS interface levels.
18, 19	Q4, nQ4	Output		Differential output pair 4. LVDS interface levels.

[[]a] Pulldown and Pullup refers to an internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			2		pF
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ
R _{PULLUP}	Input Pullup Resistor			51		kΩ



Absolute Maximum Ratings

Exposure to absolute maximum rating conditions for extended periods may affect product reliability. Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied.

Item	Rating
Supply Voltage, V _{DD}	4.6V
Inputs, V _I	-0.5V to V _{DD} + 0.5V
Outputs, I _O Continuous Current Surge Current	10mA 15mA
Input Sink/Source, I _{REF}	±2mA
Maximum Junction Temperature, T _{J,MAX}	150°C
Storage Temperature, T _{STG}	-65°C to 150°C
ESD - Human Body Model ^[a]	2000V
ESD - Charged Device Model ^{Note 1}	1500V

[[]a] According to JEDEC JS-001-2012/JESD22-C101E.

Recommended Operating Conditions

Symbol	Parameter	Minimum	Typical	Maximum	Units
T _A	Ambient air temperature	-40		85	°C
T _J	Junction temperature			125	°C

NOTE 1: It is the user's responsibility to ensure that device junction temperature remains below the maximum allowed.

DC Electrical Characteristics

Table 3A. Power Supply DC Characteristics, V_{DD} = 1.8V ± 5%, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Power Supply Voltage		1.71	1.8	1.89	V
I _{DD}	Power Supply Current	Q0 to Q5 terminated 100 Ω between nQx, Qx		100	114	mA

NOTE 2: All conditions in the table must be met to guarantee device functionality.

NOTE 3: The device is verified to the maximum operating junction temperature through simulation.



Table 3B. Differential Input Characteristics, $V_{DD} = 1.8V \pm 5\%$, $T_A = -40$ °C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
I _{IH}	Input High Current	CLK, nCLK	V _{IN} = V _{DD} = 1.89V			150	μΑ
	Input Low Current	CLK	V _{IN} = 0V, V _{DD} = 1.89V	-10			μΑ
IIL	Input Low Current	nCLK	V _{IN} = 0V, V _{DD} = 1.89V	-150			μΑ
V _{REF}	Reference Voltage for	Input Bias ^[a]	I _{REF} = +100μA, V _{DD} = 1.8V	0.9		1.30	٧
V _{PP}	Peak-to-Peak Voltage Note3.		V _{DD} = 1.89V	0.2		1.0	٧
V_{CMR}	Common Mode Input Voltage ^{[b] [c]}			0.9		V _{DD} – (V _{PP} /2)	٧

[[]a] V_{REF} specification is applicable to the AC-coupled input interfaces shown in *Figures 2B and 2C*.

Table 3C. LVDS DC Characteristics, V_{DD} = 1.8V ± 5%, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{OD}	Differential Output Voltage	Outputs Loaded with 100Ω	247	350	454	mV
ΔV_{OD}	V _{OD} Magnitude Change				50	mV
Vos	Offset Voltage		1.0	1.23	1.4	V
ΔV _{OS}	V _{OS} Magnitude Change				50	mV

[[]b] Common mode input voltage is defined as crosspoint voltage.

[[]c] V_{IL} should not be less than -0.3V and V_{IH} should not be higher than V_{DD} .



AC Electrical Characteristics

Table 4. AC Electrical Characteristics, V_{DD} = 1.8V ± 5%, T_A = -40°C to 85°C^[a]

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f _{REF}	Input Frequency	CLK, nCLK				1.2	GHz
ΔV/Δt	Input Edge Rate	CLK, nCLK		1.5			V/ns
t _{PD}	Propagation I	Delay ^[b]	CLK, nCLK to any Qx, nQx for V _{PP} = 0.4V	190	290	400	ps
tsk(o)	Output Skew	[c] [d]			20	40	ps
<i>t</i> sk(p)	Pulse Skew		f _{REF} = 100MHz		4	20	ps
<i>t</i> sk(pp)	Part-to-Part S	Skew ^[e]				250	ps
			f _{REF} = 122.88MHz Square Wave, V _{PP} = 1V, Integration Range: 1kHz – 40MHz		117	221	fs
			f _{REF} = 122.88MHz Square Wave, V _{PP} = 1V, Integration Range: 10kHz – 20MHz		89	110	fs
			f _{REF} = 122.88MHz Square Wave, V _{PP} = 1V, Integration Range: 12kHz – 20MHz		85	110	fs
	Buffer Additiv	re Phase	f _{REF} = 156.25MHz Square Wave, V _{PP} = 1V, Integration Range: 1kHz – 40MHz		52	107	fs
t_{JIT}	Jitter, RMS; r Additive Phas	efer to	f _{REF} = 156.25MHz Square Wave, V _{PP} = 1V, Integration Range: 10kHz – 20MHz		40	78	fs
	Section		f _{REF} = 156.25MHz Square Wave, V _{PP} = 1V, Integration Range: 12kHz – 20MHz		39	78	fs
			f_{REF} = 156.25MHz Square Wave, V_{PP} = 0.5V, Integration Range: 1kHz – 40MHz		51	112	fs
			f _{REF} = 156.25MHz Square Wave, V _{PP} = 0.5V, Integration Range: 10kHz – 20MHz		37	85	fs
			f _{REF} = 156.25MHz Square Wave, V _{PP} = 0.5V, Integration Range: 12kHz – 20MHz		36	85	fs
+ /+	Output Diss!	Fall Time	10% to 90% outputs loaded with 100 Ω		270	400	ps
ι _R / ί _F	Output Rise/ Fall Time		20% to 80% outputs loaded with 100Ω		162	260	ps

[[]a] Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

[[]b] Measured from the differential input crossing point to the differential output crossing point

[[]c] Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential cross points.

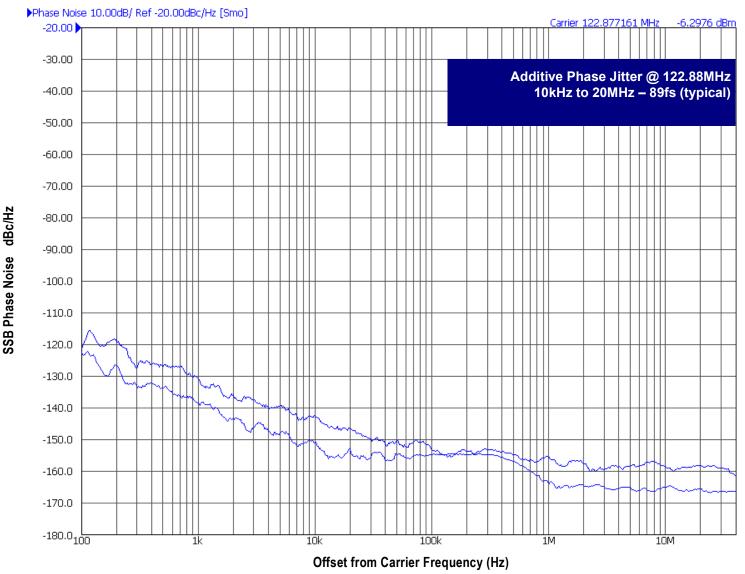
[[]d] This parameter is defined in accordance with JEDEC Standard 65.

[[]e] Defined as skew between outputs on different devices operating at the same supply voltage, same frequency, same temperature and with equal load conditions. Using the same type of input on each device, the outputs are measured at the differential cross points.



Additive Phase Jitter

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the *dBc Phase Noise*. This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio of the power in the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a *dBc* value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.

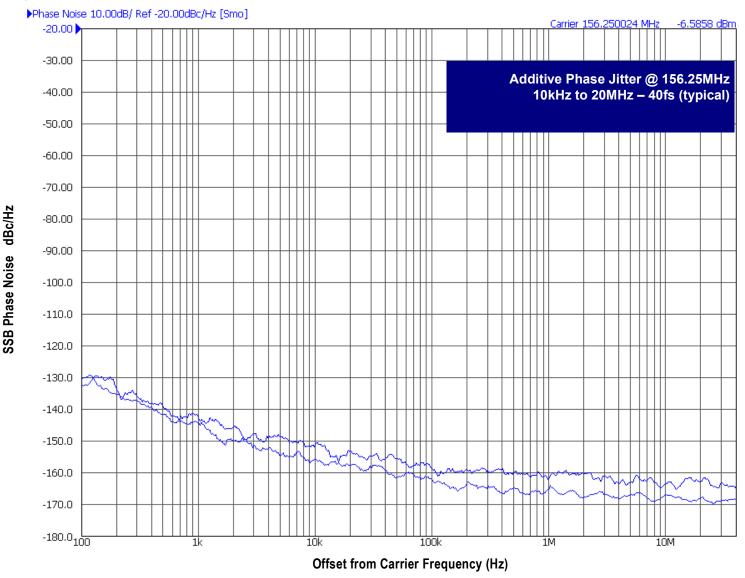


As with most timing specifications, phase noise measurements have issues relating to the limitations of the measurement equipment. The noise floor of the equipment can be higher or lower than the noise floor of the device. Additive phase noise is dependent on both the noise floor of the input source and measurement equipment. Measured using a Rohde & Schwarz SMA 100 A Signal Generator as the input source.



Additive Phase Jitter

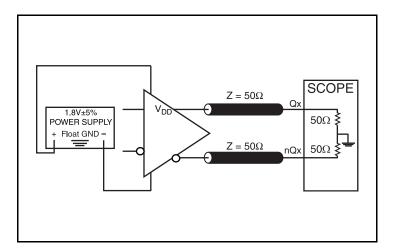
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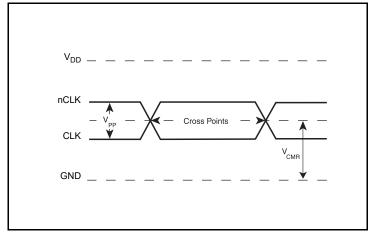


As with most timing specifications, phase noise measurements have issues relating to the limitations of the measurement equipment. The noise floor of the equipment can be higher or lower than the noise floor of the device. Additive phase noise is dependent on both the noise floor of the input source and measurement equipment. Measured using a Wenzel 156.25MHz Oscillator as the input source.

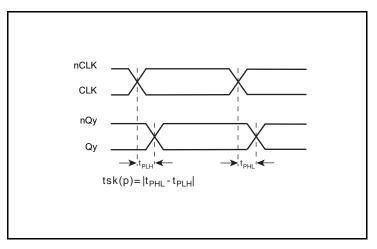


Parameter Measurement Information

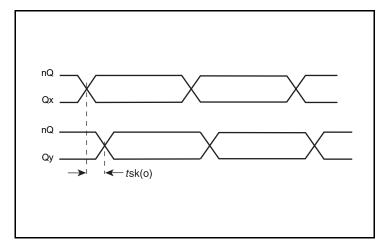




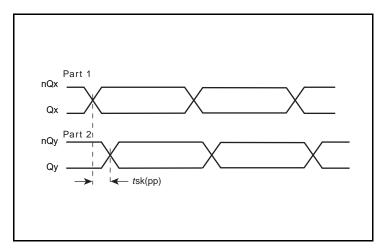
1.8V LVDS Output Load Test Circuit



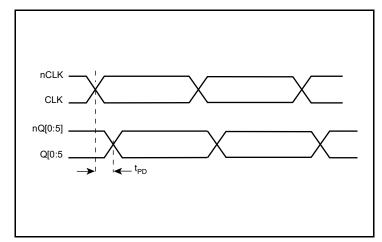
Differential Input Level



Pulse Skew



Output Skew

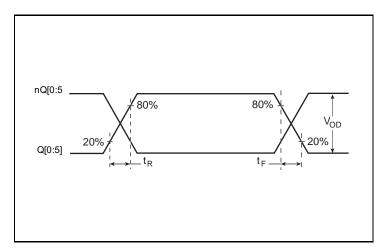


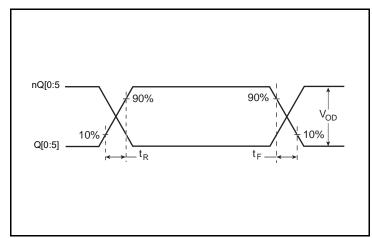
Part-to-Part Skew

Propagation Delay



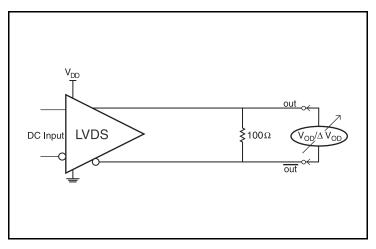
Parameter Measurement Information, continued

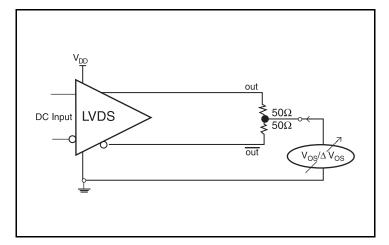




Output Rise/Fall Time, 20% - 80%

Output Rise/Fall Time, 10% - 90%





Differential Output Voltage Setup

Offset Voltage Setup



Applications Information

Wiring the Differential Input to Accept Single-Ended Levels

Figure 1A and Figure 1B show examples of how a differential input can be wired to accept single-ended levels. The values below are for when both the single ended swing and VDD are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission line impedance and the signal DC offset after AC coupling should be equal to V1. For most Zo = 50Ω applications, R3 = 100Ω and R4 can be 100Ω .

By keeping the same R3/R4 ratio, the values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the input can handle larger amplitude signaling, it is recommended that the amplitude be reduced. For single-ended applications, the swing can be larger. Make sure the single-ended logic high and logic low signal operates within specification limit. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

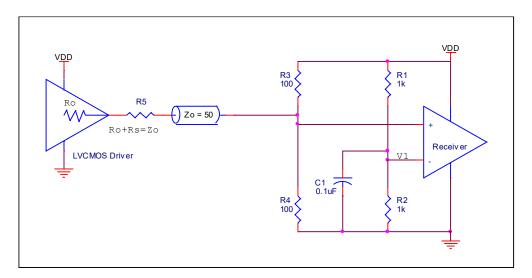


Figure 1A. DC Coupling Example for Wiring a Differential Input to Accept Single-ended Levels

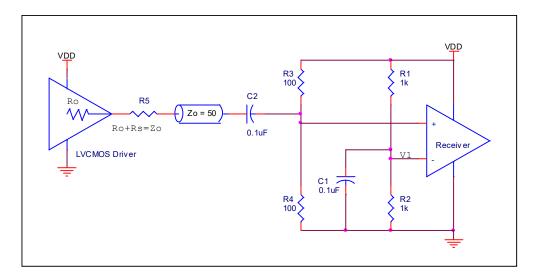


Figure 1B. AC Coupling Example for Wiring a Differential Input to Accept Single-ended Levels



Recommendations for Unused Output Pins

Outputs

LVDS Outputs

Unused LVDS outputs must either have a 100Ω differential termination or have a 100Ω pull-up resistor to V_{DD} in order to ensure proper device operation.

1.8V Differential Clock Input Interface

The CLK /nCLK accepts LVDS and other differential signals. The differential input signal must meet both the V_{PP} and V_{CMR} input requirements. *Figures 2A to 2D* show interface examples for the CLK /nCLK input driven by the most common driver types. The input

interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.

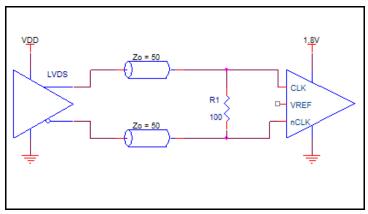
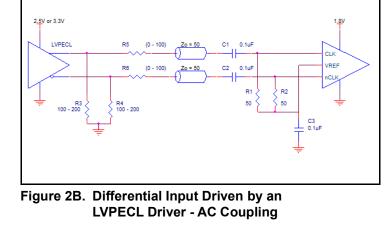


Figure 2A. Differential Input Driven by an LVDS Driver - DC Coupling



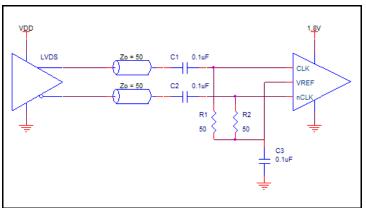


Figure 2C. Differential Input Driven by an LVDS Driver - AC Coupling

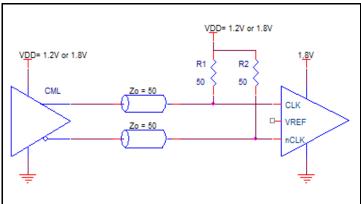


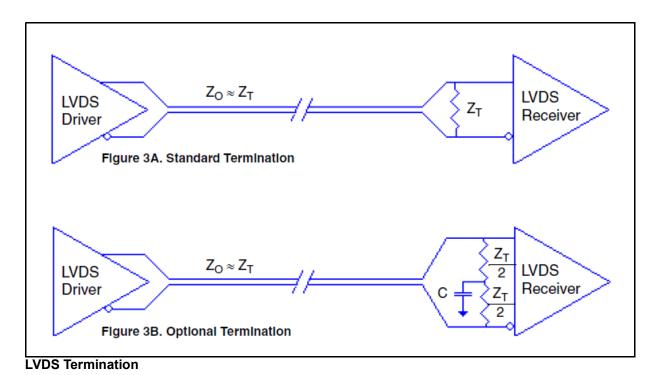
Figure 2D. Differential Input Driven by a CML Driver



LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance (Z_T) is between 90Ω and $132\Omega.$ The actual value should be selected to match the differential impedance (Z_0) of your transmission line. A typical point-to-point LVDS design uses a 100Ω parallel resistor at the receiver and a 100Ω differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. Renesas offers a full line of LVDS compliant devices with two types of output structures: current source and voltage

source. The standard termination schematic as shown in Figure 3A can be used with either type of output structure. Figure 3B, which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50pF. If using a non-standard termination, it is recommended to contact Renesas and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.





VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in Figure 4. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements.

Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Leadframe Base Package, Amkor Technology.

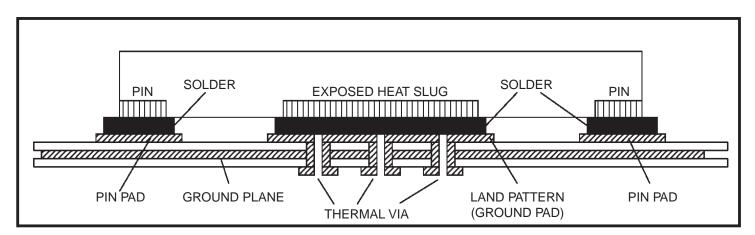


Figure 4. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)



Power Considerations

This section provides information on power dissipation and junction temperature for the 8P34S1106I. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the 8P34S1106I is the sum of the core power plus the output power dissipation due to the load. The following is the power dissipation for $V_{DD} = 1.8V + 5\% = 1.89V$, which gives worst case results.

The maximum current at 85°C is as follows:

$$I_{DD\ MAX} = 107mA$$

Power (core)MAX = V_{DD_MAX} * I_{DD_MAX} = 1.89V * 107mA = 202.23mW

Total Power _{MAX} = 202.23mW

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + TA

Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 62.2°C/W per Table 5 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

 $85^{\circ}\text{C} + 0.203\text{W} * 62.2^{\circ}\text{C/W} = 97.6^{\circ}\text{C}$. This is below the limit of 125°C .

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 5. Thermal Resistance θ_{JA} for 20 Lead VFQFN

	θ_{JA} at 0 Air Flow		
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	62.2°C/W	54.4°C/W	48.8°C/W



Reliability Information

Table 6. θ_{JA} vs. Air Flow Table for a 20-lead VFQFN

	θ_{JA} vs. Air Flow		
Meters per Second	0	1	2.5
Multi-Layer PCB, JEDEC Standard Test Boards	62.2°C/W	54.4°C/W	48.8°C/W

Transistor Count

The transistor count for the 8P34S1106I is: 976

Package Outline Drawings

The package outline drawings are located at the end of this document and are accessible from the Renesas website (see Ordering Information for POD links). The package information is the most current data available and is subject to change without revision of this document.

Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
8P34S1106NLGI	8P34S1106NLGI	4.0 × 4.0 × 0.9 mm 20-VFQFPN	Tray	-40°C to 85°C
8P34S1106NLGI8	8P34S1106NLGI	4.0 × 4.0 × 0.9 mm 20-VFQFPN	Tape & Reel	-40°C to 85°C

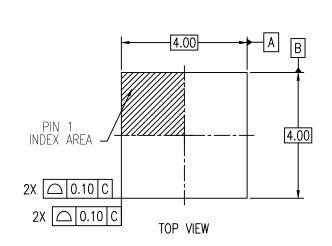
Revision History

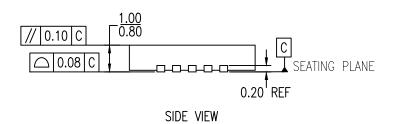
Revision Date	Description of Change
May 10, 2021	 Updated Ordering Information; changed Shipping Packaging from "Tube" to "Tray"; added link to POD in Package column. Updated Package Outline Drawings section.
September 8, 2020	Updated the section "Wiring the Differential Input to Accept Single-Ended Levels".
October 18, 2019	 Corrected the "shipping packaging" information for 8P34S1106NLGI in Ordering Information Completed other minor changes
November 29, 2018	Updated the description of Absolute Maximum Ratings Added Recommended Operating Conditions Updated the Package Outline Drawings; however, no technical changes
December 17, 2015	Initial release.

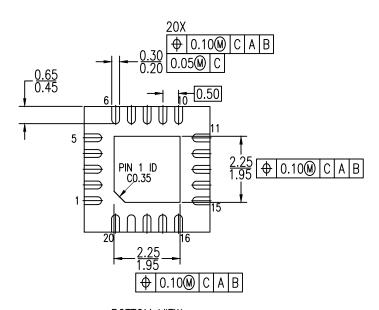


20-VFQFPN, Package Outline Drawing

4.0 x 4.0 x 0.9 mm Body, 0.5mm Pitch, Epad 2.1 x 2.1 mm NLG20P1, PSC-4170-01, Rev 01, Page 1







BOTTOM VIEW

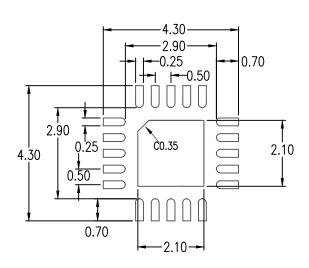
NOTES:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. ALL DIMENSIONING AND TOLERANCING CONFROM TO ANSI Y14.5M-1982.



20-VFQFPN, Package Outline Drawing

4.0 x 4.0 x 0.90 mm Body, 0.5mm Pitch, Epad 2.1 x 2.1 mm NLG20P1, PSC-4170-01, Rev 01, Page 2



RECOMMENDED LAND PATTERN DIMENSION

NOTES:

- 1. ALL DIMENSIONING AND TOLERANCING CONFORM TO ANSI Y14.5M-1994
- 2. ALL DIMENSONS ARE IN MILLIMETERS
- 3. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUIREMENT FOR SURFACE MOUNT DESIGN AND LAND PATTERN

Package Revision History		
Date Created	Rev No.	Description
March 1, 2018	Rev 01	New Format, Add P1, Re-calculate Land Pattern
May 19, 2016	Rev 00	Initial Release

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